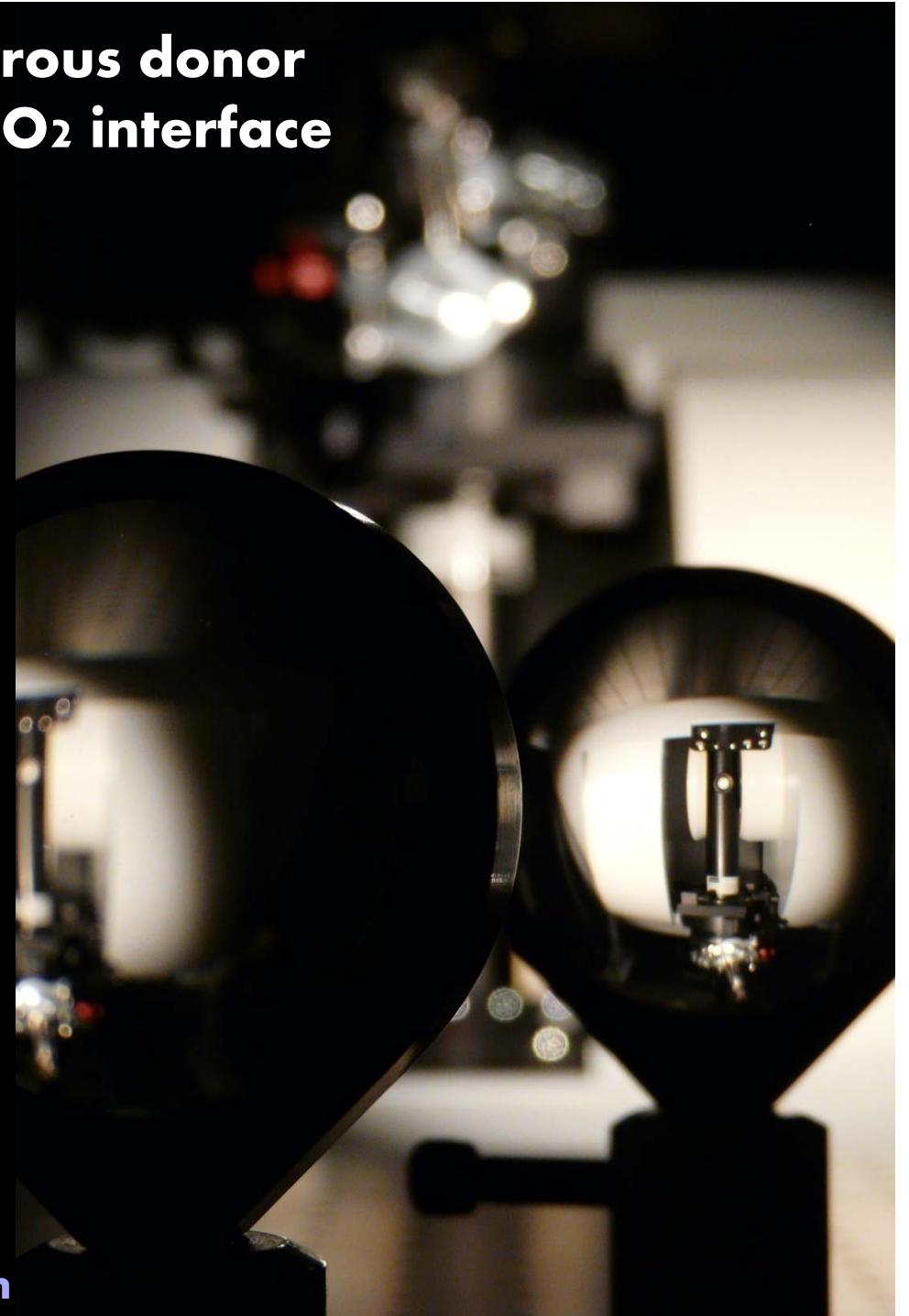


# **Spin (in)coherence of phosphorous donor electron qubits near the c-Si/SiO<sub>2</sub> interface**

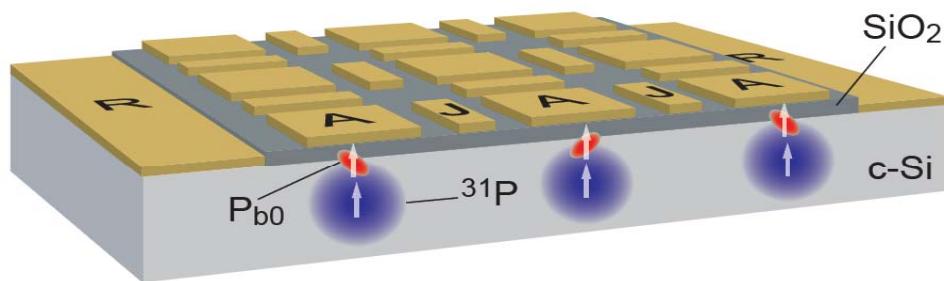


**Christoph Boehme**  
**Department of Physics University of Utah**

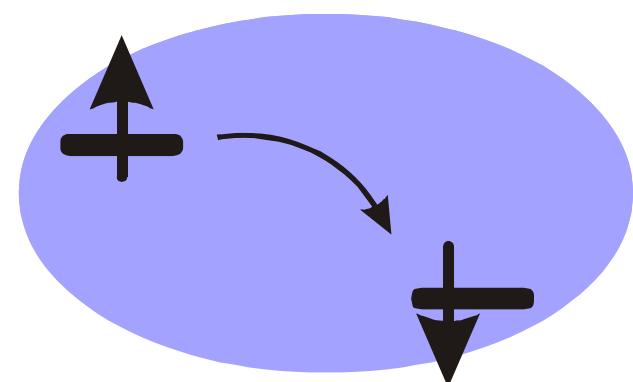
# SPIN DEVICES BASED ON CRYSTALLINE SILICON

Spin will play an increasingly important role in (silicon based) electronics

## Quantum Information Processing



electrode  
for  
indirect  
coherent  
coherence  
transition  
collection  
coherent  
spin state



$$0 \left| \langle \uparrow \downarrow | \psi \rangle \right|^2 = \frac{1}{2}$$

Electron spin  $T_2$  time of  $^{31}\text{P}$  donor  
 $> 600\text{ms}$  (electron spin) \*

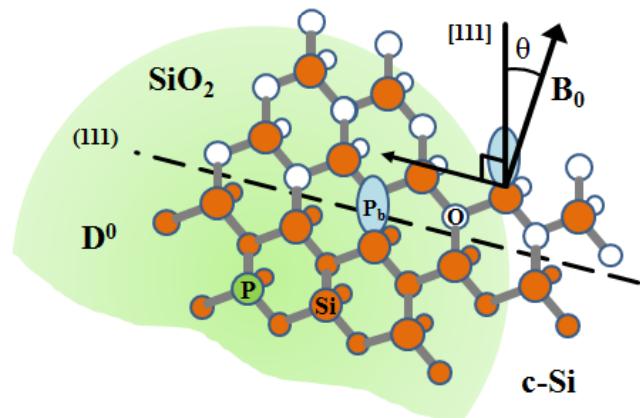
\*A. M. TYRYSKIN et al. PHYSICAL REVIEW B 68, 193207 (2003)

\* John J. MORTON Alexei M. TYRYSKIN et al. Nature, vol. 455, 1085 (2008)

How does the readout of  $^{31}\text{P}$  qubit work? SPIN – SELECTION RULES!

# PHOSPHOROUS SPIN READOUT AT THE SILICONDIOXIDE INTERFACE

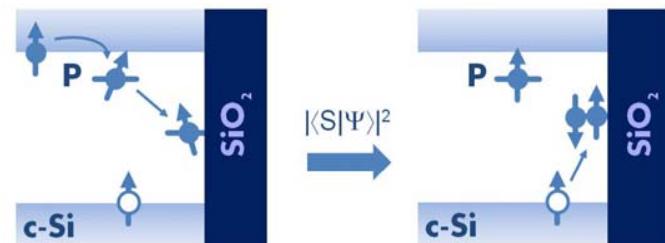
## The c-Si (111)/SiO<sub>2</sub> interface



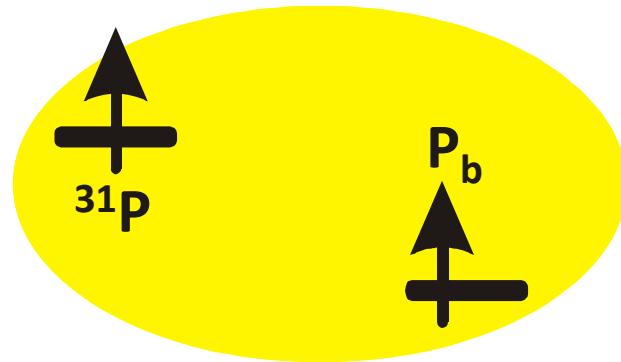
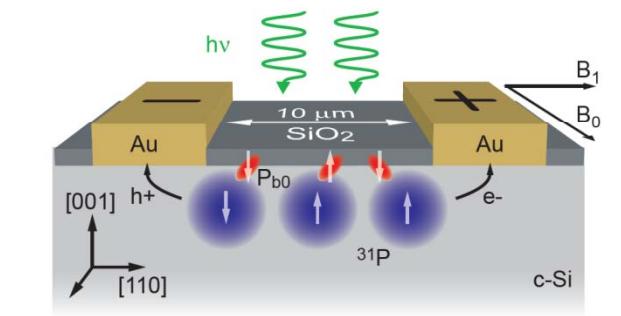
P.M. Lenahan, J. K. Conley, J. Vac. Sci. Technol. B (1998)

## <sup>31</sup>P SPIN READOUT USING SPIN-SELECTION RULES

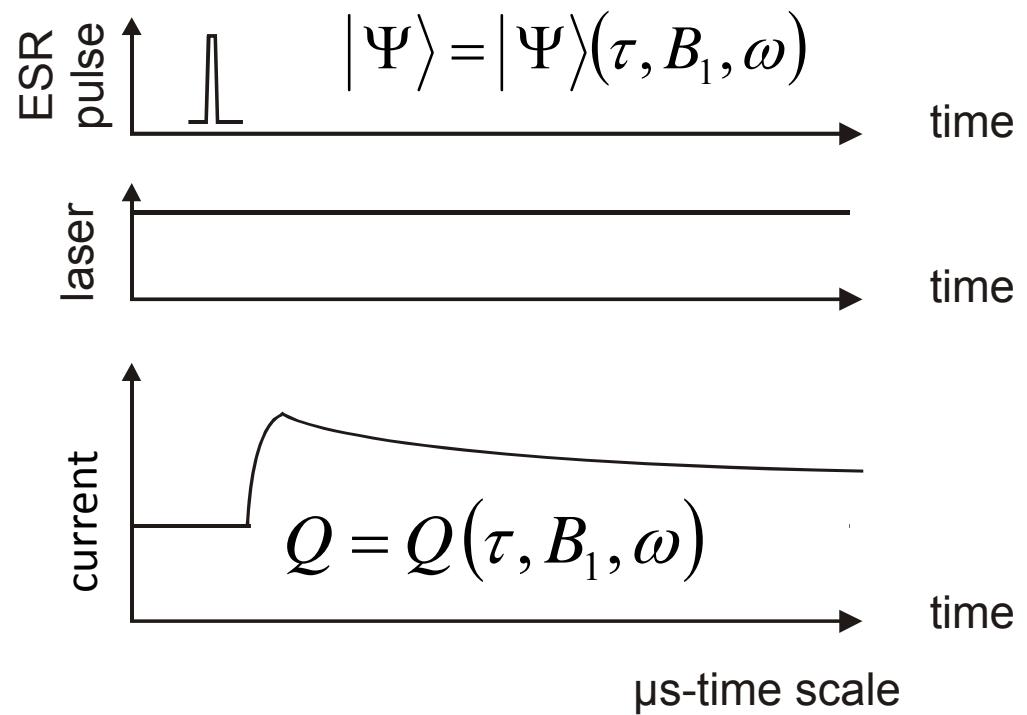
A. R. Stegner et al. *Nature Physics* (2006)  
D. R. McCamey et al. *Appl. Phys. Lett.* (2006)



# OBSERVATION OF THE PHOSPHOROUS – INTERFACE DEFECT TRANSITION



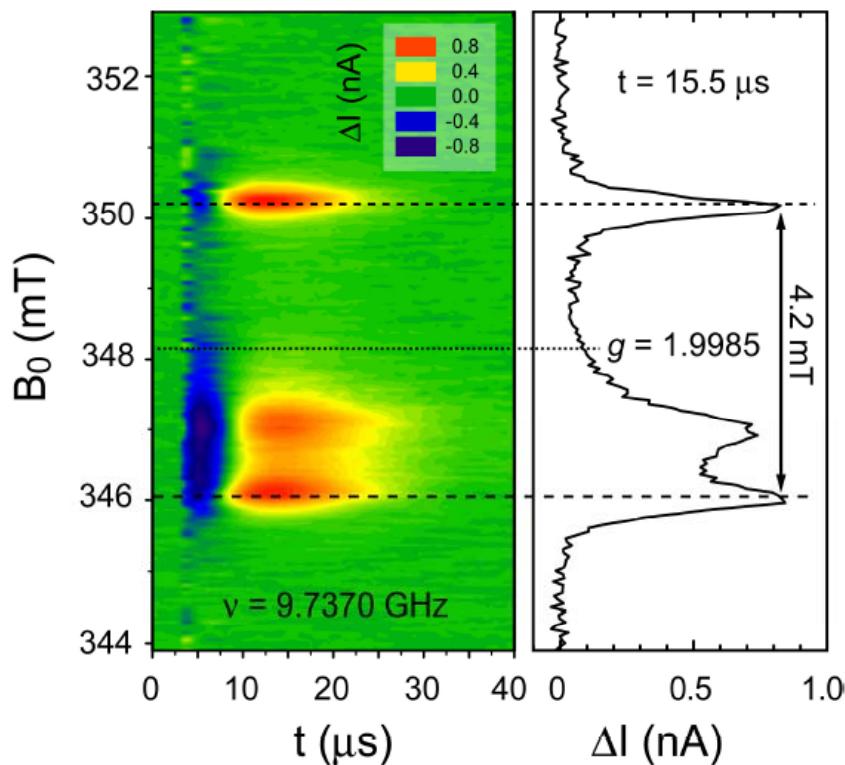
$$|\Psi_+\rangle\rangle$$



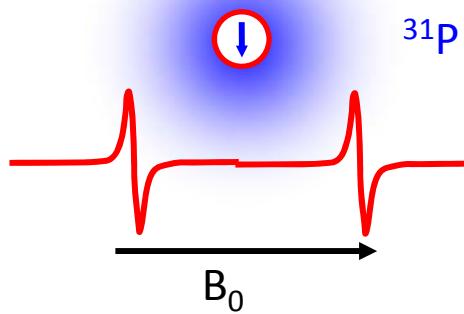
$$Q \propto |\langle S | \Psi \rangle|^2$$

# ELECTRICAL DETECTION OF $^{31}\text{P}$ DONOR STATES

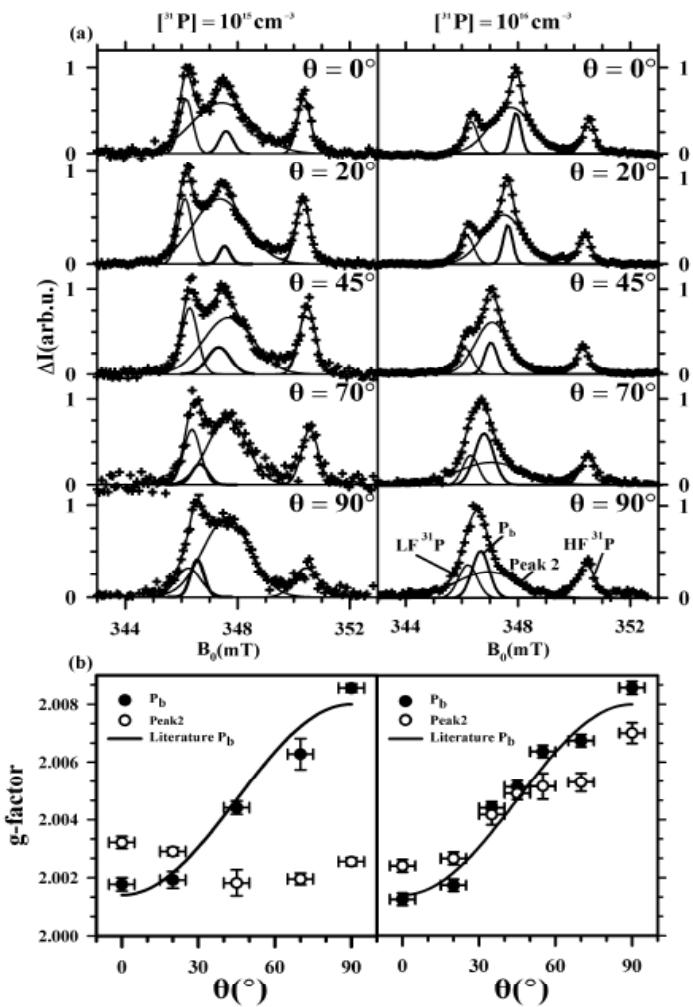
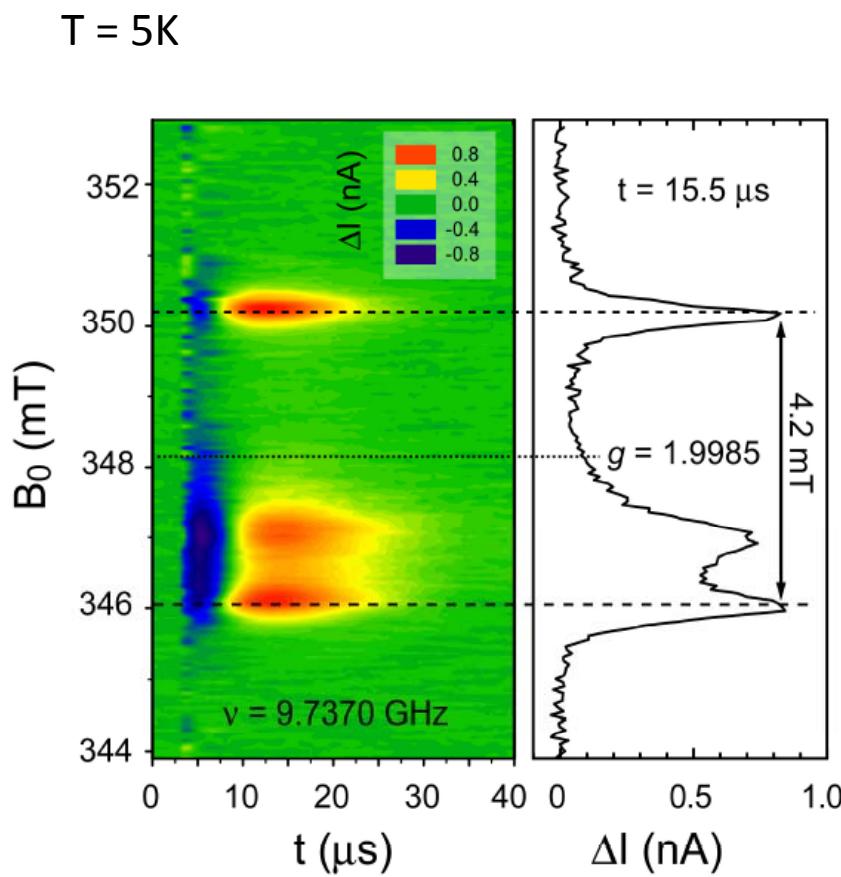
$T = 5\text{K}$



$$|\Psi(r=0)|^2 \propto \Delta \text{HFS} = 4.2 \text{ mT} \propto a^{-3}$$

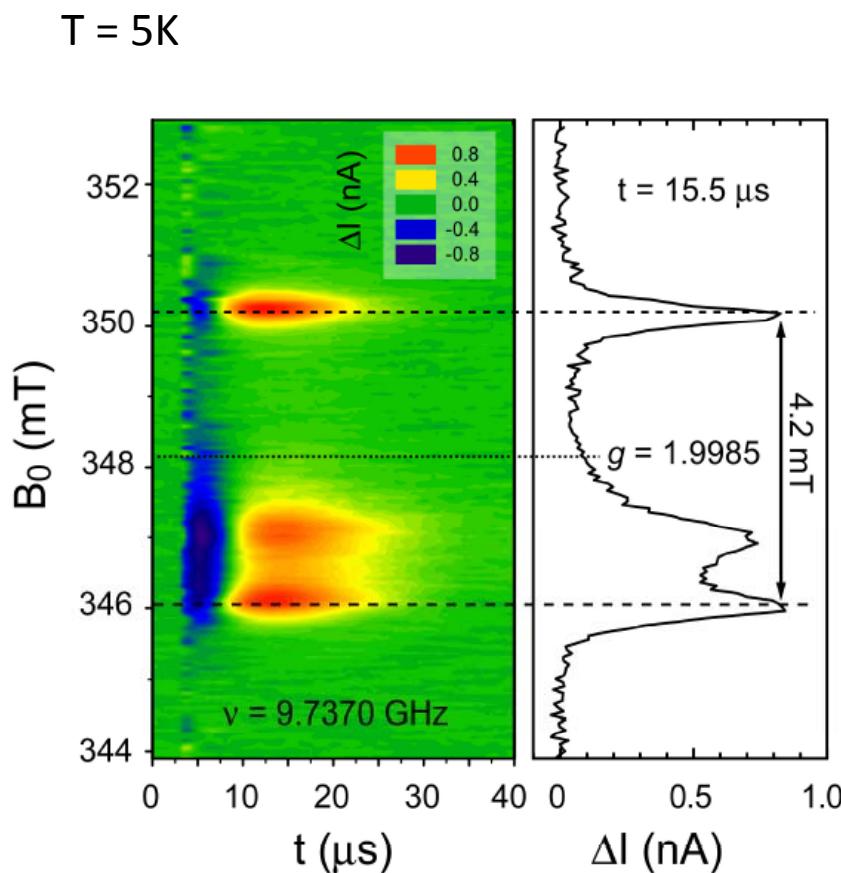


# ELECTRICAL DETECTION OF $^{31}\text{P}$ DONOR STATES

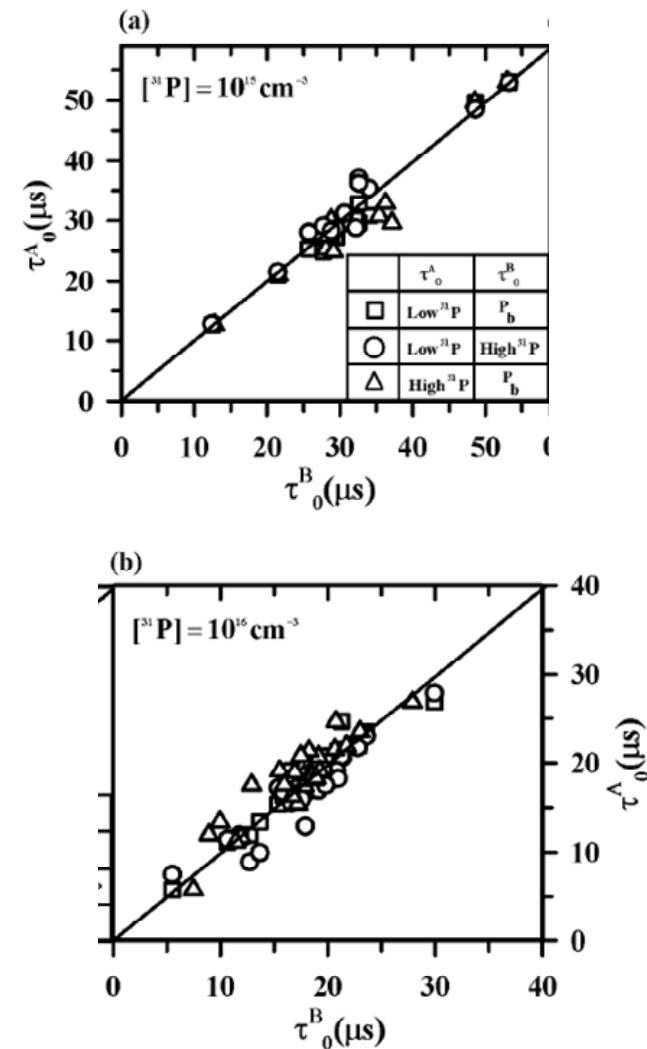


Seoyoung Paik et al. arXiv:0905.0416v1 (2009)

# ELECTRICAL DETECTION OF $^{31}\text{P}$ DONOR STATES



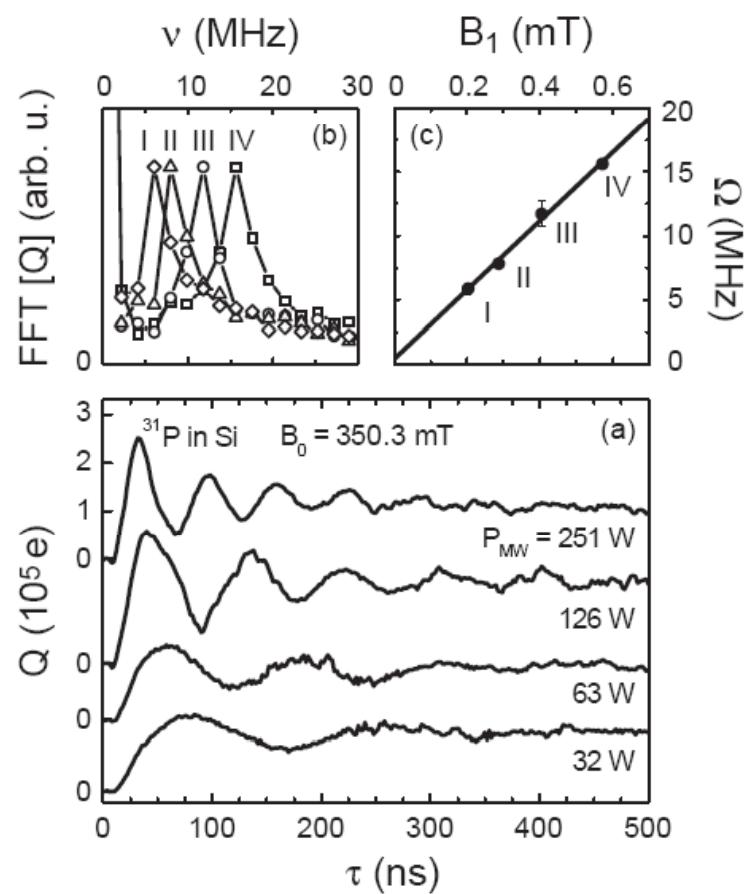
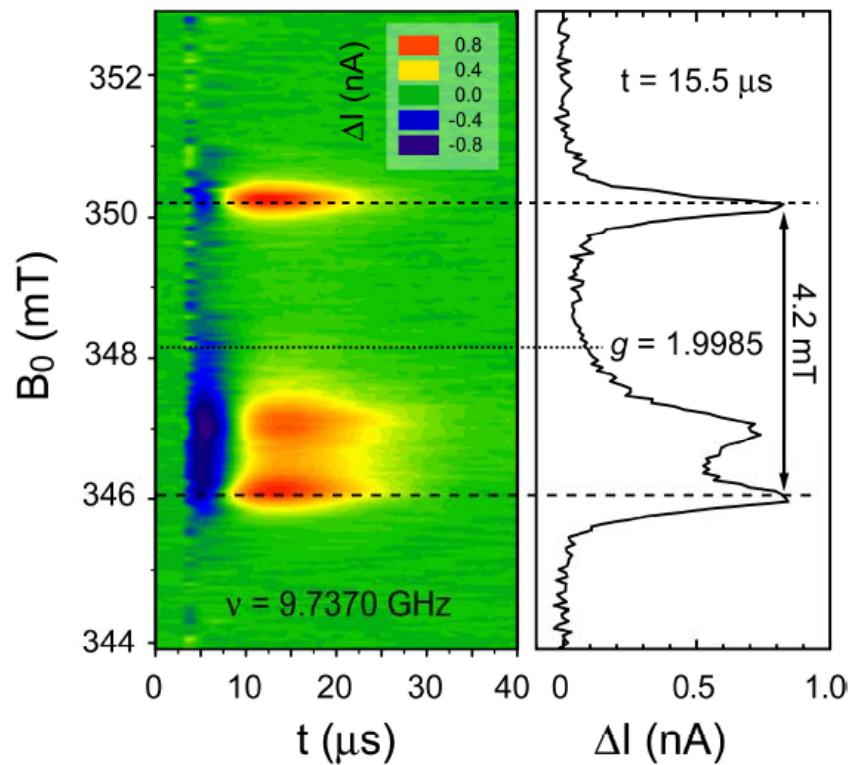
$$Q \propto \left| \langle S | \Psi \rangle \right|^2 ?$$



Seoyoung Paik et al. arXiv:0905.0416v1 (2009)

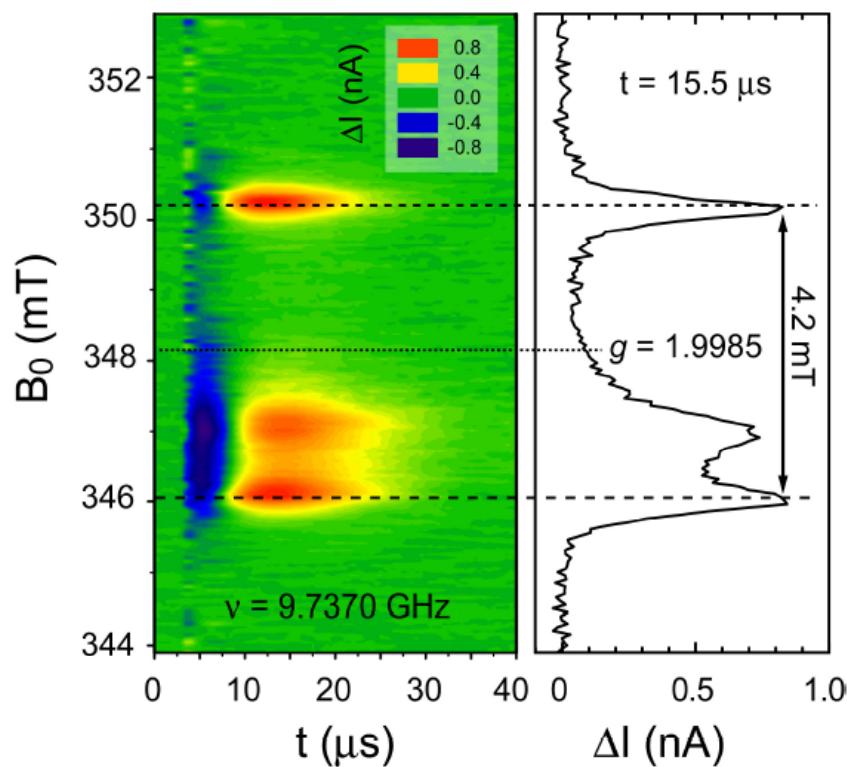
# ELECTRICAL DETECTION OF $^{31}\text{P}$ DONOR STATES

$T = 5\text{K}$

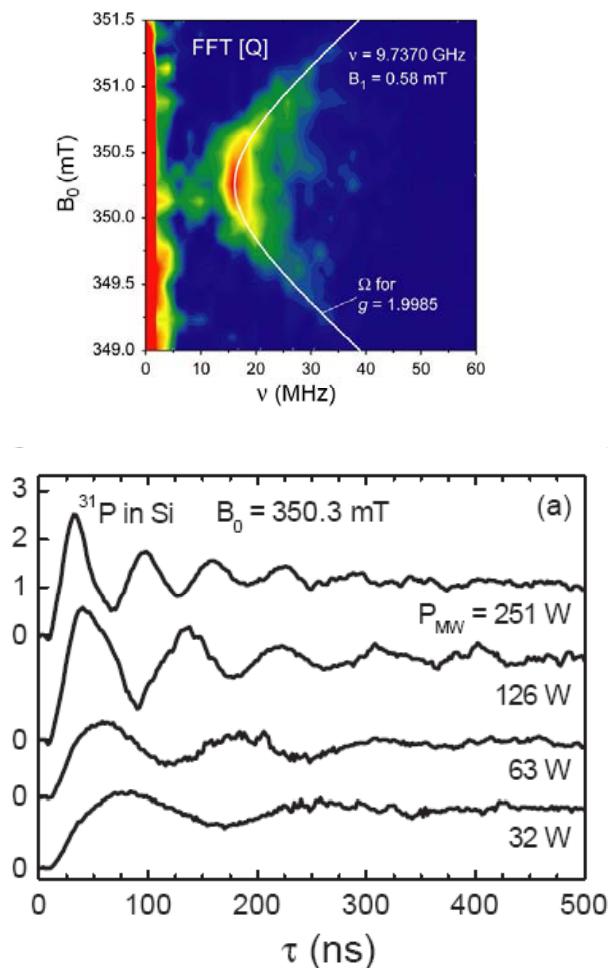


# ELECTRICAL DETECTION OF $^{31}\text{P}$ DONOR STATES

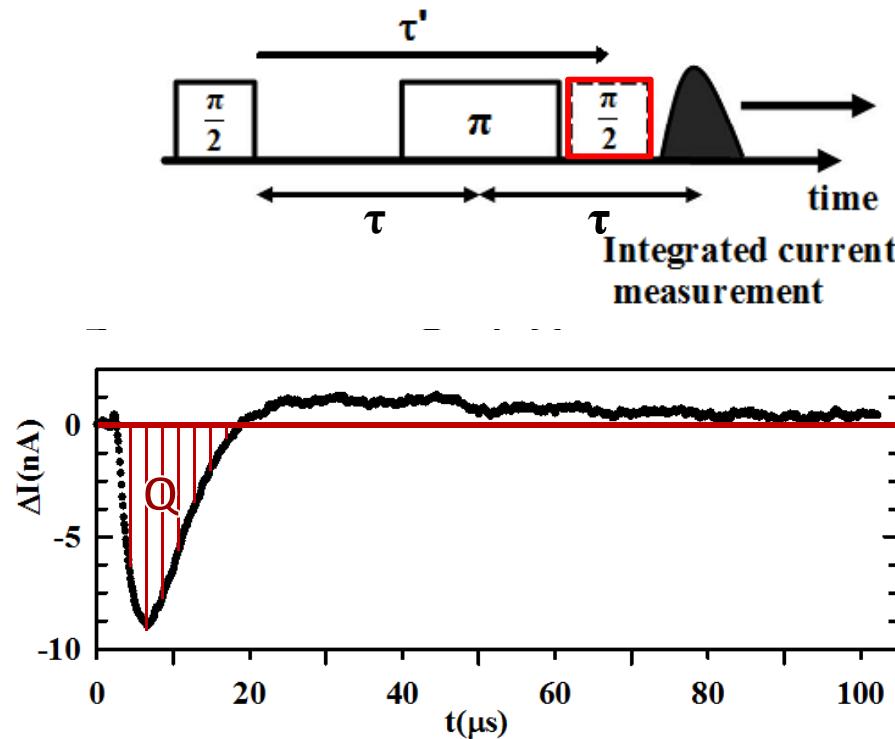
T = 5K



Weakly coupled  $^{31}\text{P}-\text{P}_b$  spin pairs



# ELECTRICALLY DETECTED HAHN-ECHOES OF NEAR INTERFACE $^{31}\text{P}$

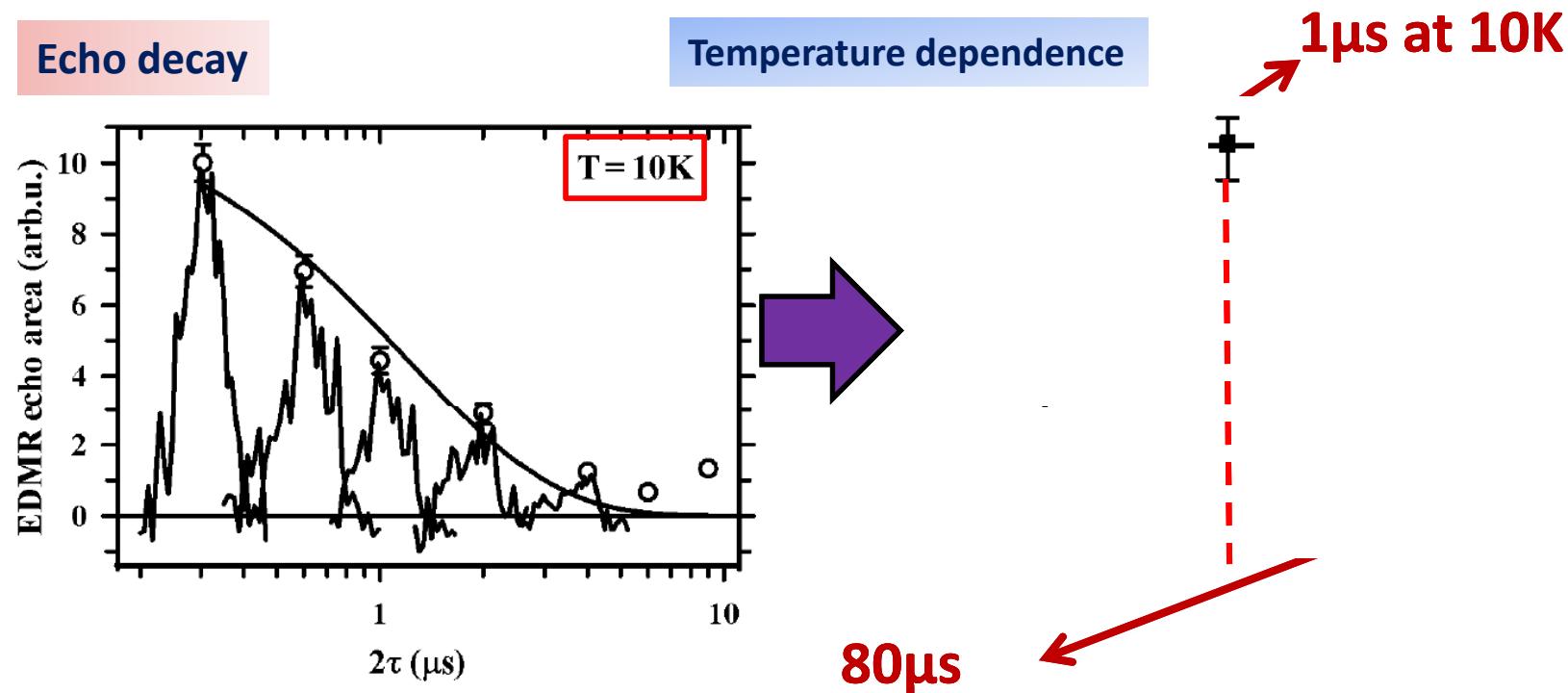


Increase dephasing time  $\tau$

Echo intensity decays

Decay time :  $T_2$  coherence time

## ELECTRICALLY MEASURED T<sub>2</sub> RELAXATION



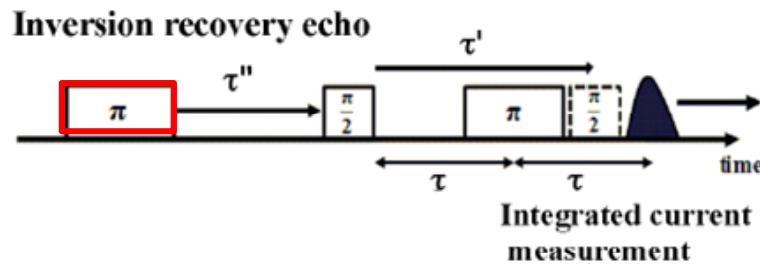
- T<sub>2</sub> time at interface is const. at different temperatures.
- ESR T<sub>2</sub> has temperature dependence : T<sub>1</sub> limits T<sub>2</sub> in the ESR measurement.\*
- T<sub>2</sub> time at interface is much shorter than in bulk T<sub>2</sub> at low temperature.

\* A. M. Tyryshkin et al. PHYSICAL REVIEW B 68, 193207 (2003)

# ELECTRICALLY DETECTED INVERSION RECOVERY EXPERIMENT

**IS SPIN RELAXATION TIME  
TRULY LIMITED BY ELECTRONIC  
TRANSITION OR IS FIELD  
FLUCTUATIONS AT INTERFACE ?**

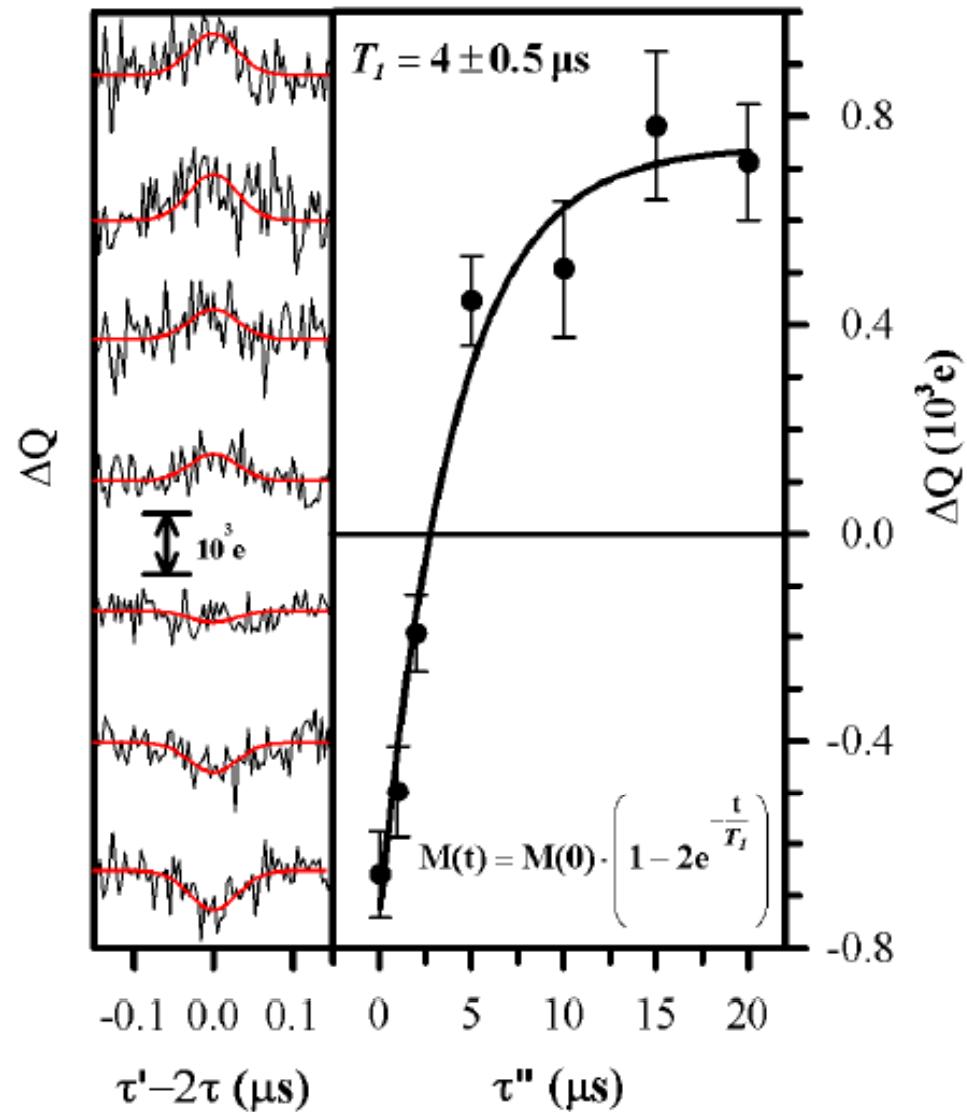
R. de Sousa,  
Phys. Rev. B 76, 245306 (2007).



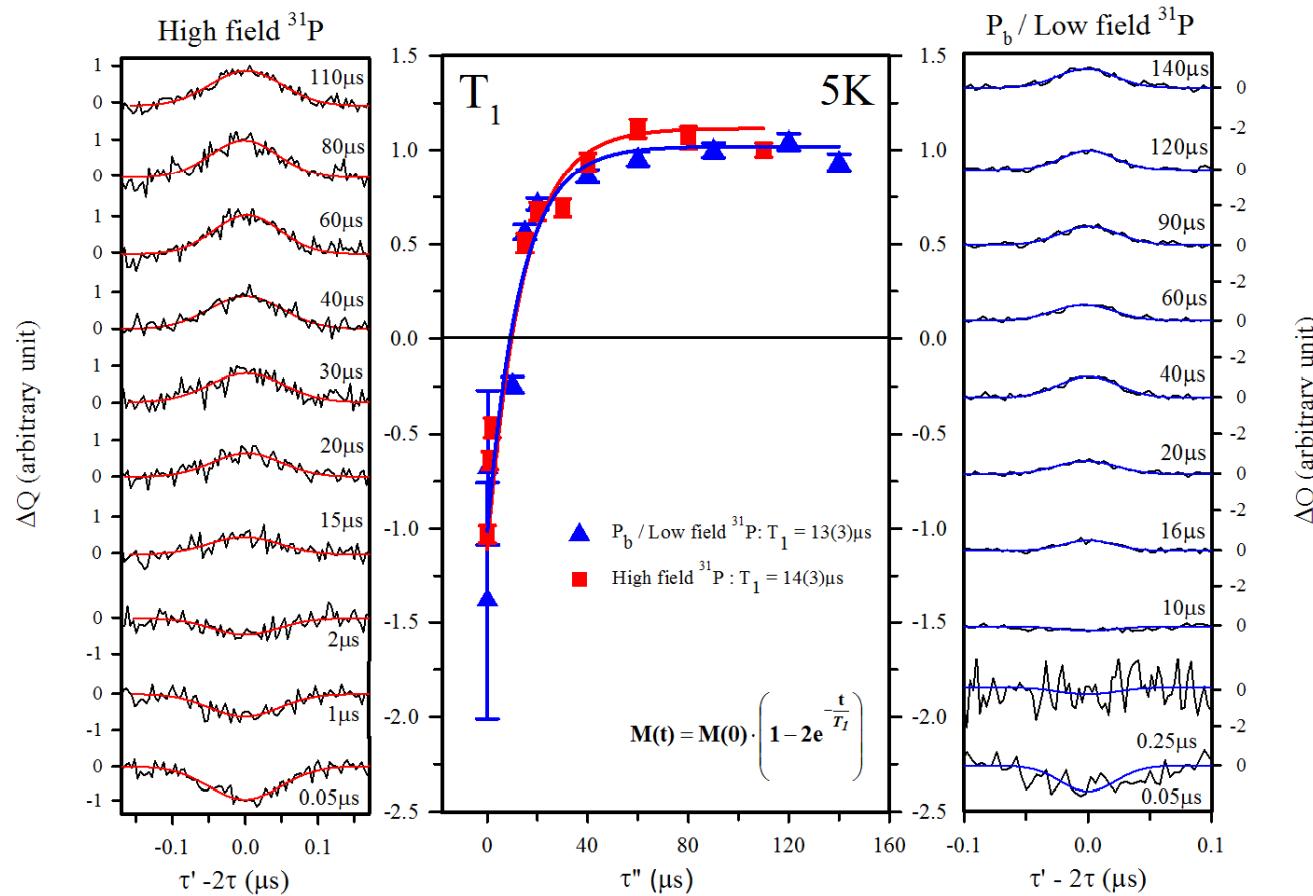
$$T_1 = 4.0(5)\mu\text{s}$$

$$T_2 = 1.3(8)\mu\text{s} \text{ at low HF } {}^{31}\text{P peak}$$

$$T_2 = 2.1(7)\mu\text{s} \text{ at high HF } {}^{31}\text{P peak}$$

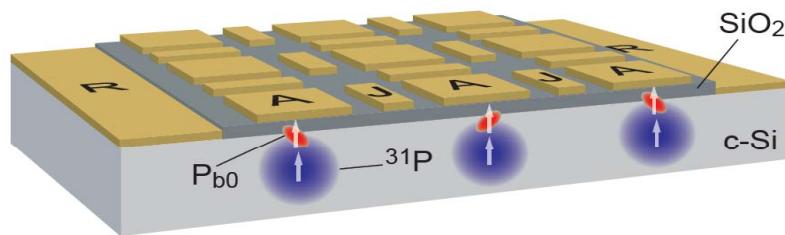


# ELECTRICALLY T<sub>1</sub> RELAXATION AT LOWER INTERFACE STATE DENSITIES



c-Si/SiO<sub>2</sub> INTERFACE WITH 4 TIMES SMALLER INTERFACE DENSITY

# RELAXATION TIMES OF NEAR INTERFACE PHOSPHOROUS DONOR STATES



T = 5K	High field $^{31}\text{P}$	Low field $^{31}\text{P} / \text{P}_b$
EDMR $T_1$	14(3) $\mu\text{s}$	13(3) $\mu\text{s}$
EDMR $T_2$	4.0(5) $\mu\text{s}$	1.0(2) $\mu\text{s}$

## CONCLUSIONS

- EDMR  $T_1, T_2$  times are much shorter than ESR  $T_2$  time.
- electronic transition time probably limits  $T_1$  relaxation time.
- Incoherence time  $T_2$  of  $^{31}\text{P}$  qubit is shortened due to the interface states.

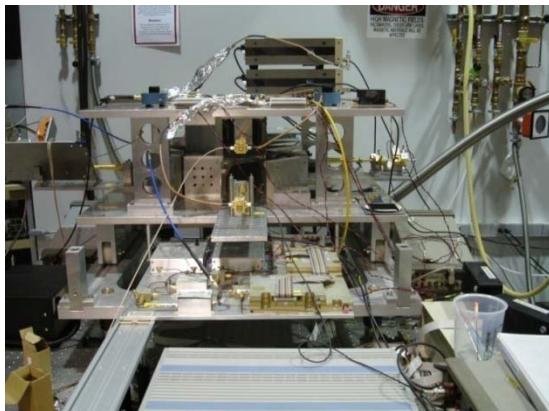
Silicon-based QCs using  $^{31}\text{P}$  qubits (AND READOUT) need to overcome the limitation imposed by interface defects

# SPIN-DEPENDENT TRAPPING AT BULK PHOSPHOROUS IN SILICON

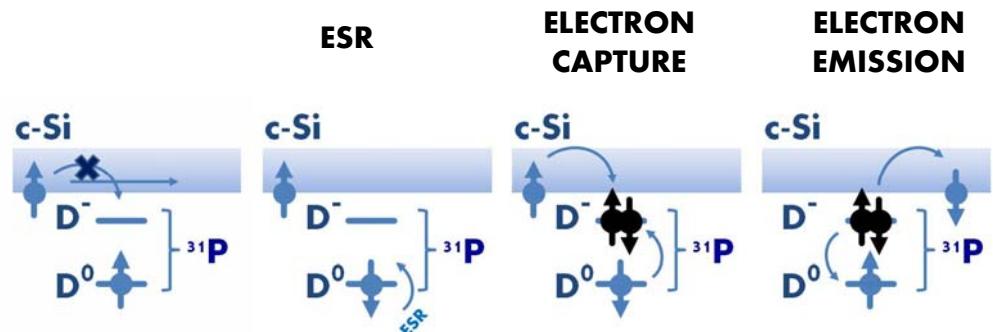
## • SPIN TRAPPING

- D. D. Thornton, A. Honig, *Phys. Rev. Lett.* (1973)

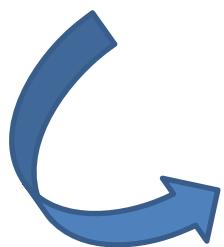
Quasi-optical  
Superheterodyne EPR System



J. van Tol *et al.*, *Rev. Sci. Instrum.* **76**,  
074101 (2005).



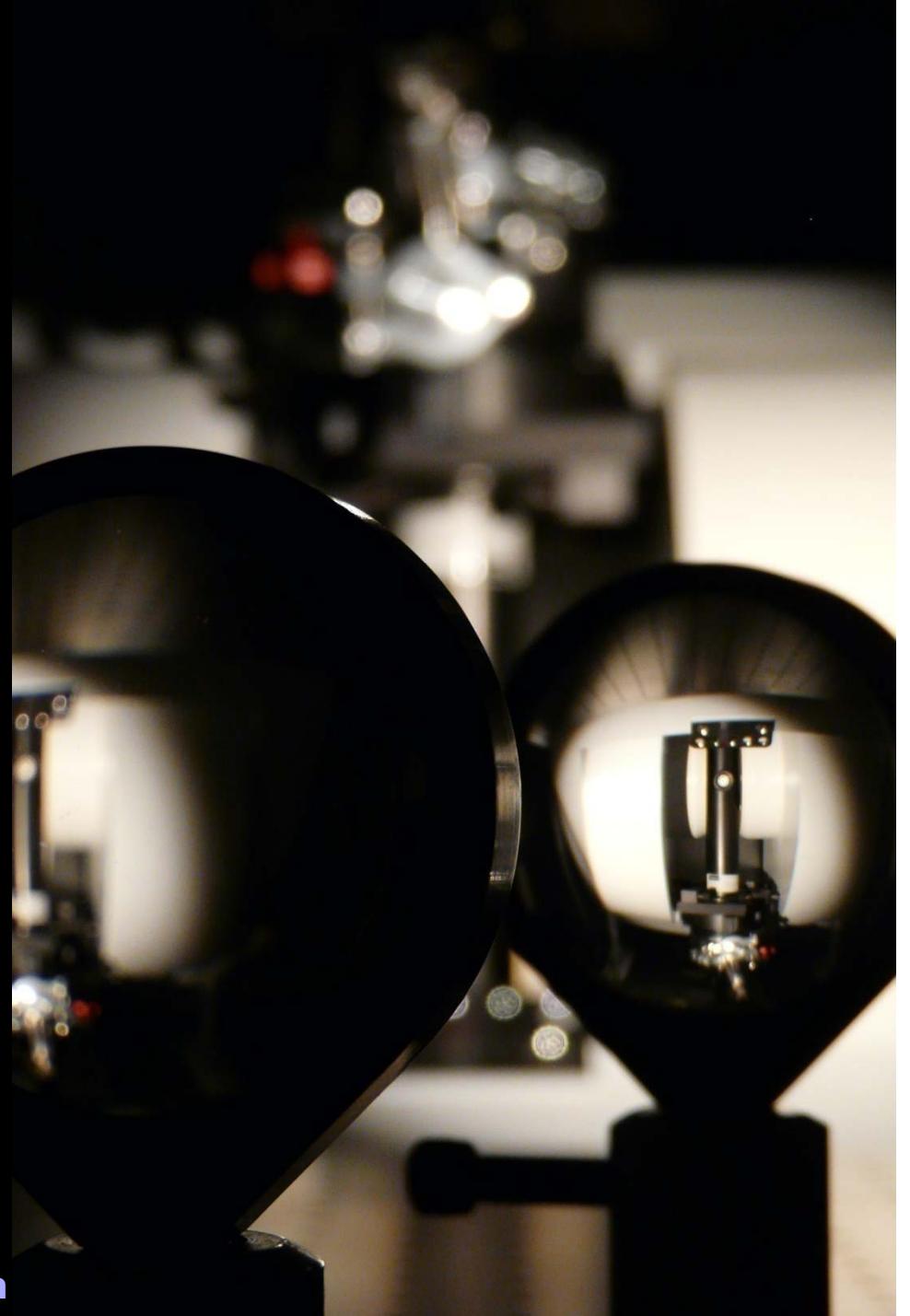
**SPIN-TRAPPING IS ONLY VISIBLE WHEN ELECTRONS ARE STRONGLY POLARIZED – AT VERY HIGH MAGNETIC FIELDS**



**SEE GAVIN MORLEYs TALK THAT WILL COME NEXT**

G. W. Morley, D. R. McCamey, H. A. Seipel, L. C. Brunel, J. van Tol & C. Boehme. *Phys. Rev. Lett.* **101**, 207602 (2008).

# Questions?



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